



Support & training



CSD23382F4

SLPS453E - MAY 2014 - REVISED JANUARY 2022

ТΜ CSD23382F4 12-V P-Channel FemtoFET MOSFET

1 Features

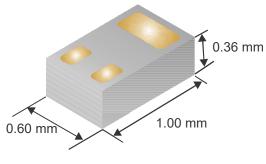
- Low on-resistance
- Ultra-low Q_g and Q_{gd} Ultra-small footprint (0402 case size) – 1.0 mm × 0.6 mm
- Low profile
 - 0.36-mm maximum height
- Integrated ESD protection diode
 - Rated > 2-kV HBM
 - Rated > 2-kV CDM
 - Pb terminal plating
- Halogen free
- **RoHS** compliant

2 Applications

- Optimized for load switch applications
- Optimized for general purpose switching applications
- **Battery applications**
- Handheld and mobile applications

3 Description

This 66-mΩ, 12-V P-channel FemtoFET[™] MOSFET is designed and optimized to minimize the footprint in many handheld and mobile applications. This technology is capable of replacing standard small signal MOSFETs while providing at least a 60% reduction in footprint size.



Typical Device Dimensions

Product Summarv

T _A = 25°	C	TYPICAL V	ALUE	UNIT			
V _{DS}	Drain-to-source voltage	ource voltage -12					
Qg	Gate charge total (-4.5 V)	1.04	nC				
Q _{gd}	Gate charge gate-to-drain	0.15	nC				
		V _{GS} = -1.8 V	149				
R _{DS(on)}	Drain-to-source on-resistance	V _{GS} = -2.5 V	90	mΩ			
		V _{GS} = -4.5 V	66	1			
V _{GS(th)}	Threshold voltage	-0.8		V			

Ordering Information⁽¹⁾

DEVICE	DEVICE QTY MEDIA PACKAGE			
CSD23382F4	3000	7-inch reel		
CSD23382F4T	250	7-inch reel	1.0 mm × 0.6 mm Land Grid Array (LGA)	Tape and reel

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Absolute Maximum Ratings

T _A = 25	°C	VALUE	UNIT
V _{DS}	Drain-to-source voltage	-12	V
V _{GS}	Gate-to-source voltage	±8	V
I _D	Continuous drain current ⁽¹⁾	-3.5	А
I _{DM}	Pulsed drain current, $T_A = 25^{\circ}C^{(2)}$	-22	А
	Continuous gate clamp current	-35	mA
I _G	Pulsed gate clamp current ⁽²⁾	-350	IIIA
PD	Power dissipation ⁽¹⁾	500	mW
V	Human body model (HBM)	2	kV
V _(ESD)	Charged device model (CDM)	2	kV
T _J , T _{stg}	Operating junction and storage temperature range	-55 to 150	°C

- Typical $R_{\theta JA}$ = 85°C/W on 1-inch² (6.45 cm²), 2-oz. (1) (0.071-mm thick) Cu pad on a 0.06-inch (1.52 mm) thick FR4 PCB.
- (2) Pulse duration $\leq 100 \ \mu s$, duty cycle $\leq 1\%$

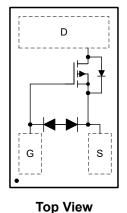




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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

С	hanges from Revision D (October 2021) to Revision E (January 2022)	Page
•	Changed maximum height from "0.35-mm" to "0.36-mm" in <i>Features</i> section	1
•	Changed maximum height from "0.35-mm" to "0.36-mm" in Typical Device Dimensions	1
•	Changed maximum height from "0.35-mm" to "0.36-mm" in Mechanical Dimensions section	8
С	hanges from Revision C (October 2014) to Revision D (October 2021)	Page
•	Updated the numbering format for tables, figures, and cross-references throughout the document	1
•	Added footnote with link to support document	9
С	hanges from Revision B (July 2014) to Revision C (October 2014)	Page
•	Corrected timing V _{DS} to read –6 V	3



5 Specifications

5.1 Electrical Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC	CHARACTERISTICS				I	
BV _{DSS}	Drain-to-Source Voltage	V _{GS} = 0 V, I _{DS} = -250 μA	-12			V
I _{DSS}	Drain-to-Source Leakage Current	V _{GS} = 0 V, V _{DS} = -9.6 V			-1	μA
I _{GSS}	Gate-to-Source Leakage Current	V _{DS} = 0 V, V _{GS} = -8 V			-10	μA
V _{GS(th)}	Gate-to-Source Threshold Voltage	V _{DS} = V _{GS} , I _{DS} = 250 μA	-0.5	-0.8	-1.1	V
		V _{GS} = -1.8 V, I _{DS} = -0.1 A		149	199	mΩ
R _{DS(on)}	Drain-to-Source On-Resistance	$V_{GS} = -2.5 \text{ V}, \text{ I}_{DS} = -0.5 \text{ A}$		90	105	mΩ
		$V_{GS} = -4.5 \text{ V}, \text{ I}_{DS} = -0.5 \text{ A}$		66	76	mΩ
g _{fs}	Transconductance	V _{DS} = -10 V, I _{DS} = -0.5 A		3.4		S
DYNAM	IC CHARACTERISTICS				1	
C _{iss}	Input Capacitance			180	235	pF
C _{oss}	Output Capacitance	$V_{GS} = 0 V, V_{DS} = -6 V,$ f = 1 MHz		118	154	pF
C _{rss}	Reverse Transfer Capacitance	, , , , , , ,		12.8	16.6	pF
R _G	Series Gate Resistance			350		Ω
Qg	Gate Charge Total (-4.5 V)			1.04	1.35	nC
Q _{gd}	Gate Charge Gate-to-Drain	$V_{DS} = -6 V. I_{DS} = -0.5 A$		0.15		nC
Q _{gs}	Gate Charge Gate-to-Source	$v_{DS} = -6 v, I_{DS} = -0.5 A$		0.50		nC
Q _{g(th)}	Gate Charge at V _{th}			0.18		nC
Q _{oss}	Output Charge	$V_{DS} = -6 V, V_{GS} = 0 V$		1.08		nC
t _{d(on)}	Turn On Delay Time			28		ns
t _r	Rise Time	V _{DS} = -6 V, V _{GS} = -4.5 V,		25		ns
t _{d(off)}	Turn Off Delay Time	$I_{DS} = -0.5 \text{ A}, \text{R}_{G} = 2 \Omega$		66		ns
t _f	Fall Time			41		ns
DIODE	CHARACTERISTICS				1	
V _{SD}	Diode Forward Voltage	I _{SD} = -0.5 A, V _{GS} = 0 V		-0.75	-1	V
Q _{rr}	Reverse Recovery Charge	V _{DS} = -6 V, I _F = -0.5 A, di/dt = 200 A/µs		1.8		nC
t _{rr}	Reverse Recovery Time	v_{DS} – o v, r_{F} – –0.5 A, di/dt – 200 A/µs		8.4		ns

5.2 Thermal Information

(T_A = 25°C unless otherwise stated)

	THERMAL METRIC	TYP	UNIT
	Junction-to-Ambient Thermal Resistance ⁽¹⁾	85	°C/W
R _{θJA}	Junction-to-Ambient Thermal Resistance ⁽²⁾	245	C/ W

(1) Device mounted on FR4 material with 1-inch² (6.45 cm²), 2-oz. (0.071-mm thick) Cu.

(2) Device mounted on FR4 material with minimum Cu mounting area.



5.3 Typical MOSFET Characteristics

(T_A = 25°C unless otherwise stated)

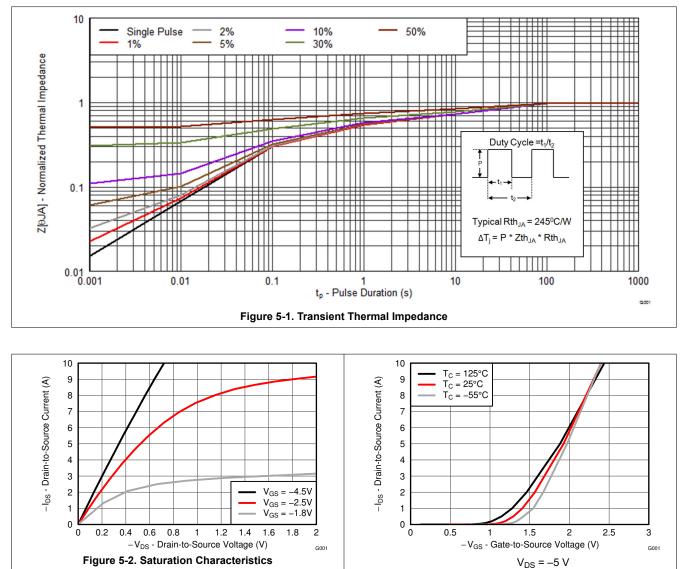
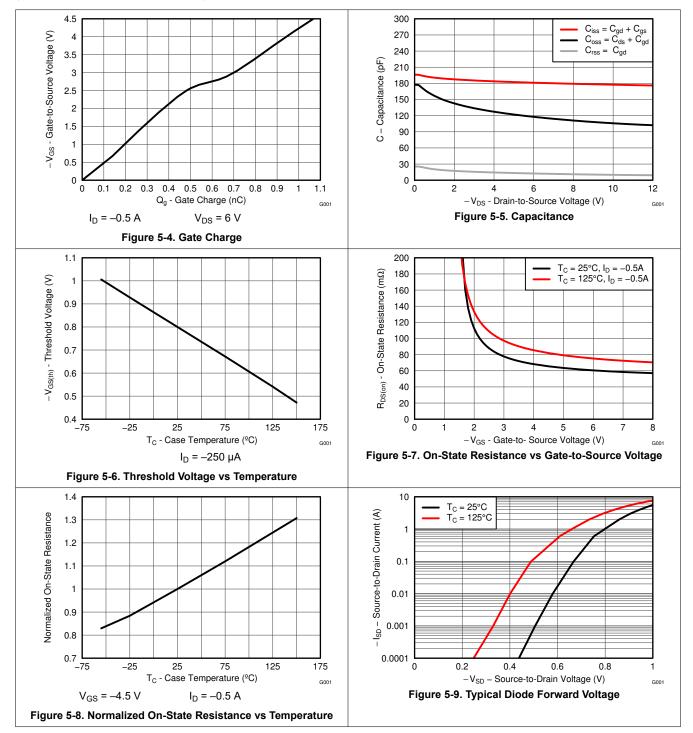


Figure 5-3. Transfer Characteristics



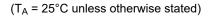
5.3 Typical MOSFET Characteristics (continued)

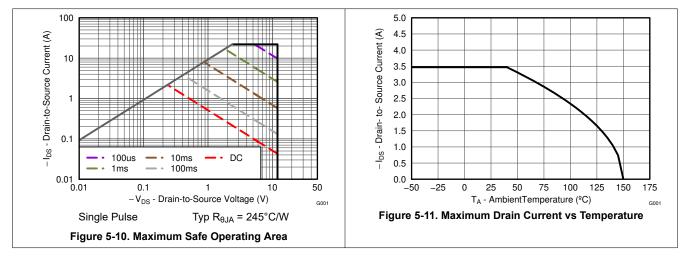
(T_A = 25°C unless otherwise stated)





5.3 Typical MOSFET Characteristics (continued)







6 Device and Documentation Support

6.1 Trademarks

FemtoFET[™] is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

6.2 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

6.3 Glossary

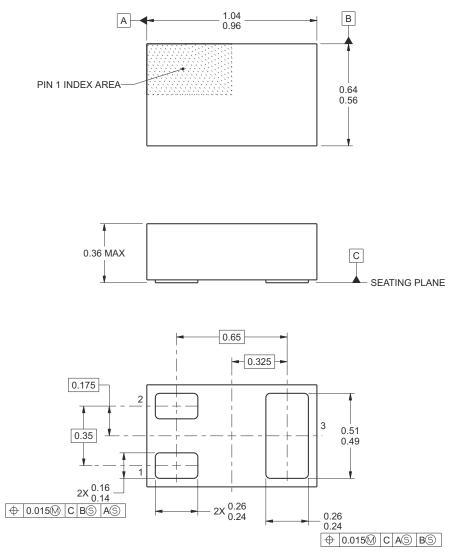
TI Glossary This glossary lists and explains terms, acronyms, and definitions.



7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

7.1 Mechanical Dimensions

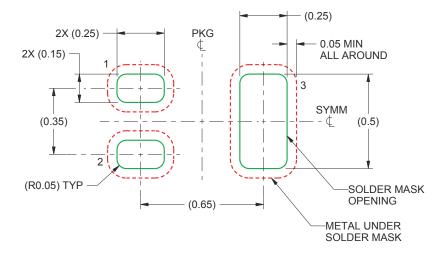


- Α. All linear dimensions are in millimeters (dimensions and tolerancing per AME T14.5M-1994).
- This drawing is subject to change without notice. Β.
- This package is a PB-free solder land design. C.

Pin Configuration							
Position	Designation						
Pin 1	Gate						
Pin 2	Source						
Pin 3	Drain						

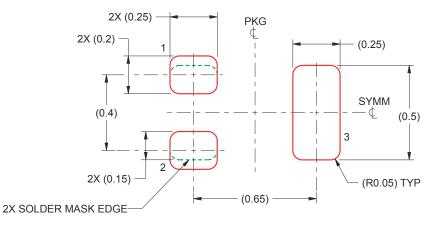


7.2 Recommended Minimum PCB Layout



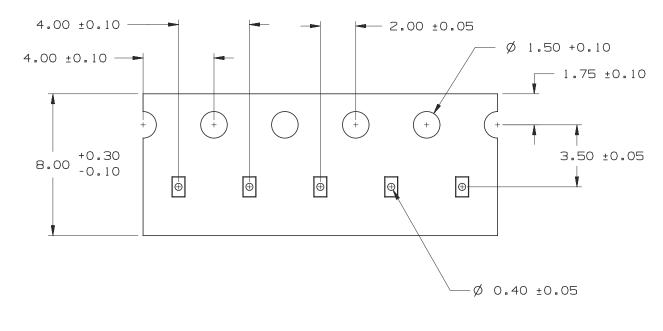
- A. All dimensions are in millimeters.
- B. For more information, see FemtoFET Surface Mount Guide (SLRA003D).

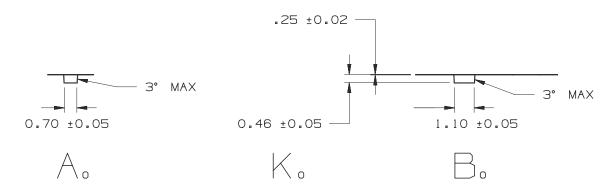
7.3 Recommended Stencil Pattern



A. All dimensions are in millimeters.

7.4 CSD23382F4 Embossed Carrier Tape Dimensions





A. Pin 1 is oriented in the top-right quadrant of the tape enclosure (quadrant 2), closest to the carrier tape sprocket holes.



PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CSD23382F4	ACTIVE	PICOSTAR	YJC	3	3000	RoHS & Green	NIAU	Level-1-260C-UNLIM	0 to 0	EM	Samples
CSD23382F4T	ACTIVE	PICOSTAR	YJC	3	250	RoHS & Green	NIAU	Level-1-260C-UNLIM	-55 to 150	EM	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

24-Jan-2022



Texas

STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All	dimensions are nominal												
Γ	Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
	CSD23382F4	PICOSTAF	YJC	3	3000	180.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2
	CSD23382F4T	PICOSTAF	YJC	3	250	180.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2



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PACKAGE MATERIALS INFORMATION

8-Jun-2024



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD23382F4	PICOSTAR	YJC	3	3000	182.0	182.0	20.0
CSD23382F4T	PICOSTAR	YJC	3	250	182.0	182.0	20.0

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